Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/014,854	SHIOZAWA ET AL.	
Examiner	Art Unit	
lacon M. Perilla	2638	

Subclass 316	Date	Examiner
316		
	9/2/2005	JP
28	12/22/2005	JP
	28	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East ' USPAT/USPGPUB	9/2/2005	JP
Inventor Name Search EAST/EDAN	12/22/2005	JP